

Realignment of Slanted Fe Nanorods on Silicon Substrates by a Strong Magnetic Field

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ABSTRACT

Slanted Fe nanorods prepared by glancing angle deposition on silicon substrates exhibited easy magnetization along their growth axis. By using a thin gold film on a silicon substrate as a buffer layer, slanted Fe nanorods can be realigned towards the substrate surface normal by a strong magnetic field. After realignment, the Fe nanorods retained the easy magnetization axis along their growth axis. The effects of the realignment by the strong magnetic field on the properties of the slanted Fe nanorods were also investigated. This study provides a possible way to fabricate magnetic nanostructures for perpendicular recording applications.

KEYWORDS

Glancing angle deposition, Fe nanorods, easy magnetization axis, strong magnetic field, reorientation

Nanomaterials, due to their reduced size at the nanometer scale, exhibit many unique physical and chemical properties that are quite different from the bulk state, and have attracted great interest in past years [1–6]. For example, at the nanometer scale, magnetic materials can exhibit superior magnetic properties, such as higher permeability and lower coercivity, compared with their bulk forms due to the single domain configuration and nanoscale effect [7–9]. This provides a way to increase the memory density of devices by fabricating nanostructures of magnetic materials. In recent years, Fe nanostructures have attracted much attention because of their potential application in nano-devices, and several approaches have been developed to grow Fe nanostructures [10–12].

An easy way to grow Fe nanostructures is the glancing angle deposition (GLAD) technique, which

has been shown to be a powerful way of fabricating 1-D nanostructures [13, 14]. In this method, the morphology (such as slanted or vertically aligned nanorods, zigzags, etc.) of the final nanostructures depends on the motion of the substrate, and greatly influences the properties of the nanostructures [15–21]. We will show later in this study that slanted and vertical Fe nanorods exhibit different magnetic properties. Since arrays of magnetic nanostructures are promising candidates for novel magnetic recording media [22, 23], we may need to devise ways to adjust their orientation and/or alignment after growth.

In this letter, we report the growth of slanted and vertically aligned Fe nanorods on silicon substrates by GLAD, the easy magnetization of slanted Fe nanorods along their growth axis, and the reorientation of the slanted Fe nanorods towards the surface normal of the substrates in a strong magnetic field. The effects

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of the reorientation by the magnetic field on the properties of the nanorods were also investigated.

The substrates used in this study were pristine Si(001) wafers. These were supersonically cleaned in acetone, alcohol, and deionized water baths in sequence and then dried by a nitrogen flow. Slanted and vertical Fe nanorods were deposited on the substrate by the GLAD technique in a home-made e-beam deposition system with a vacuum level of 3×10^{-5} Pa [14]. For the reorientation of the slanted nanorods, a gold film of 40 nm in thickness was deposited on the silicon substrates as a buffer layer, and the samples were sealed in quartz tubes with a vacuum level of 8×10^{-5} Pa and annealed in a strong magnetic field (JMTD-10T150) to 200 and 250 °C for 0.5 h. The morphology of the slanted and vertical Fe nanorods before and after annealing was examined by scanning electron microscopy (SEM, JEOL JSM 6301 working at 20 kV). The magnetic properties of the nanorods were evaluated using a vibrating sample magnetometer (Lakeshore 7307).

Figures 1(a) and 1(b), respectively, show SEM images

of the Fe nanorods obtained by deposition with the incident flux at 85° to the surface normal without substrate rotation, and with substrate rotation. Without substrate rotation, slanted Fe nanorods were deposited on the substrate, with a diameter of ~20 nm and length of ~300 nm, whereas with substrate rotation vertical Fe nanorods with larger diameter were deposited. Figures 1(c) and 1(d) show magnetic hysteresis loops of the two samples along different directions at room temperature. The measuring magnetic fields H_1 , H_2 , and H_3 , were applied parallel to the surface of the film (H_1), parallel to the axis of the nanorods (H_2), and perpendicular to the surface of the film (H_3). It should be noted that for the vertical Fe nanorods, the film did not exhibit perpendicular magnetic properties, no matter whether the field H was parallel or perpendicular to the film. However, for the slanted Fe nanorods, the film did exhibit some anisotropic magnetization properties. When H was parallel to the growth axis of the slanted Fe nanorods, the magnetization process was much easier than when H was parallel or perpendicular to the film. This suggests

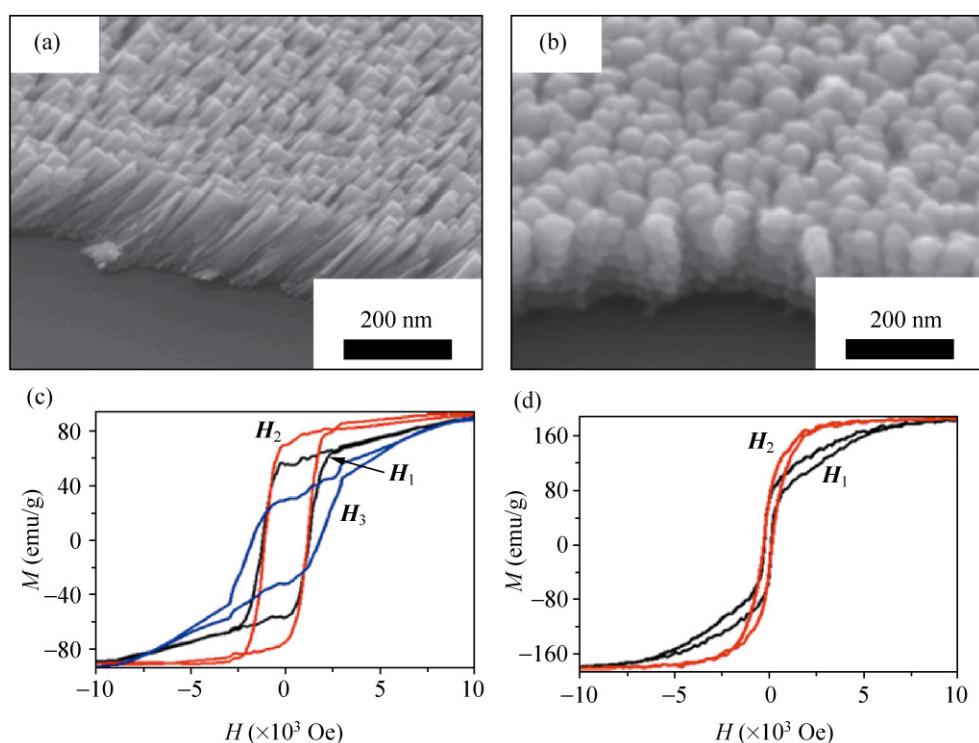


Figure 1 SEM images of (a) slanted Fe nanorods obtained by deposition at 85° off the surface normal without substrate rotation, and (b) vertical nanorods deposited with substrate rotation; (c) and (d) show magnetic hysteresis loops of the two samples along different directions, i.e., \mathbf{H} parallel to the film (H_1), \mathbf{H} parallel to the nanorod axis (H_2), and \mathbf{H} perpendicular to the film (H_3)

that the growth axis of the Fe nanorods is their easy magnetization axis.

If this growth axis of the nanorods were parallel to the surface normal of the substrate, these materials could be candidates for perpendicular magnetic recording applications. However, since these slanted Fe nanorods deviate from the surface normal of the substrates by large angles, it is thus necessary to find ways to reorient their growth axis (the easy magnetization axis) towards the substrate surface normal, before any applications in perpendicular magnetic recording materials are possible [24]. Naturally, a strong magnetic field [25] might be capable of doing this as these Fe nanorods are magnetic. For this purpose, we first deposited a thin gold film of thickness 40 nm as the buffer layer on the silicon substrate, and then deposited slanted Fe nanorods on the gold film, to make the realignment of Fe nanorods easier on the silicon substrate. We sealed the samples in quartz tubes and annealed them in a strong magnetic field of up to

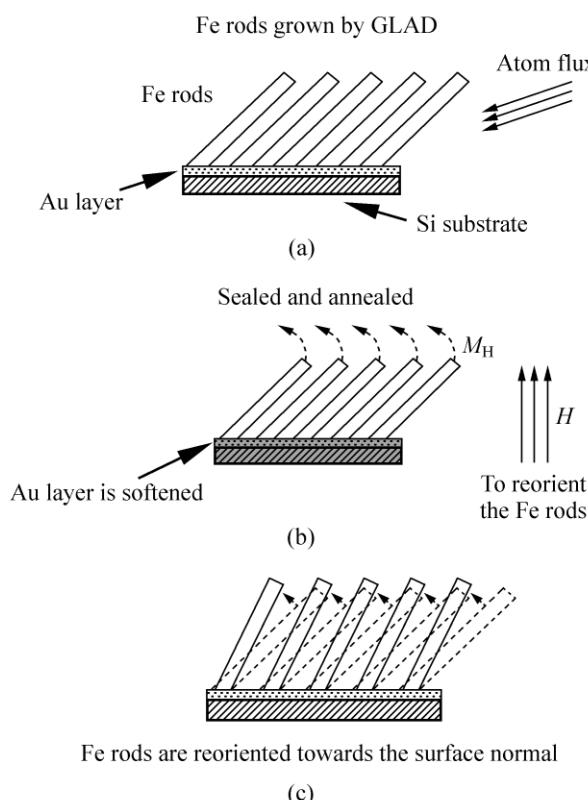


Figure 2 Schematic illustration of the use of a strong magnetic field to reorient the Fe nanorods deposited on a thin Au film as the buffer layer on the silicon substrate

10 T at temperatures of 200 °C and 250 °C for 0.5 h. The direction of the magnetic field was parallel to the substrate surface normal. Helped by the magnetic force, the slanted Fe nanorods should realign towards the surface normal [26, 27]. Figure 2 shows a schematic illustration of this process.

Figures 3 (a) and 3(b) respectively show SEM images of the as-deposited slanted Fe nanorods and after

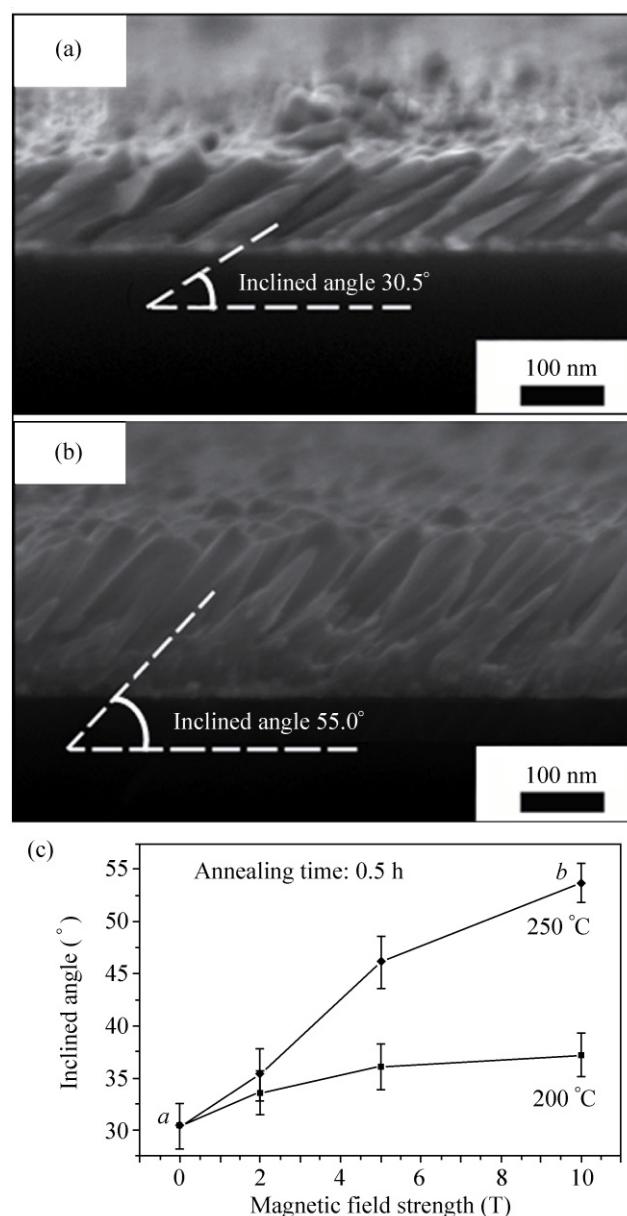


Figure 3 SEM images of (a) the as-deposited Fe nanorods and (b) after annealing at 250 °C in magnetic field of 10 T; (c) the average angle between Fe nanorods and the substrate after annealing (20 Fe nanorods were counted to minimize the statistical error, which is shown as the error bar)

annealing at 250 °C in a magnetic field of 10 T for 0.5 h. The as-deposited nanorods (Fig. 3(a)) are extremely slanted, with the angle between the substrate and the Fe nanorods being ~30°. After annealing (Fig. 3(b)), the slanted nanorods are pivoted towards the surface normal, and the angle between the Fe nanorods and the substrate increases to ~55°. In other words, the nanorods have pivoted by ~25°. To investigate the influence of the strong magnetic field on the realignment of the Fe nanorods, we carried out the annealing experiments at two temperatures of 200 and 250 °C, in magnetic fields of 2 T, 5 T, and 10 T. Figure 3(c) shows plots of the angle between the nanorods and the substrate after annealing under different conditions. At both annealing temperatures, the realignment is more effective at higher magnetic field, i.e., the angle between the nanorods and the substrate increases in the order 2 T < 5 T < 10 T. In addition, for any given field the realignment is more obvious at 250 °C than at 200 °C. This is possibly because

a higher magnetic field should generate a large torque to realign the Fe nanorods, and at higher temperatures the barrier for realignment is smaller because of the lubrication of the thin Au buffer layer.

The important point is whether the easy magnetization axis after realignment in the strong magnetic field is still along the axis of the Fe nanorods. We therefore measured the magnetic hysteresis loop of the as-deposited slanted Fe nanorods (Fig. 3(a)) and that of the nanorods after annealing at 250 °C in a 10 T magnetic field (Fig. 3(b)). During the measurements the magnetic field (H) was in the plane of the substrate surface normal and the axis of the Fe nanorods, and the angle between the substrate surface and the magnetic field (H) was set at 0°, 30°, 60°, and 90°. An angle of 90° means that the magnetic field is perpendicular to the substrate surface. Figures 4(a) and 4(b) respectively show the hysteresis loops measured for the two samples along different directions. It was found that for the as-deposited slanted Fe nanorods, the

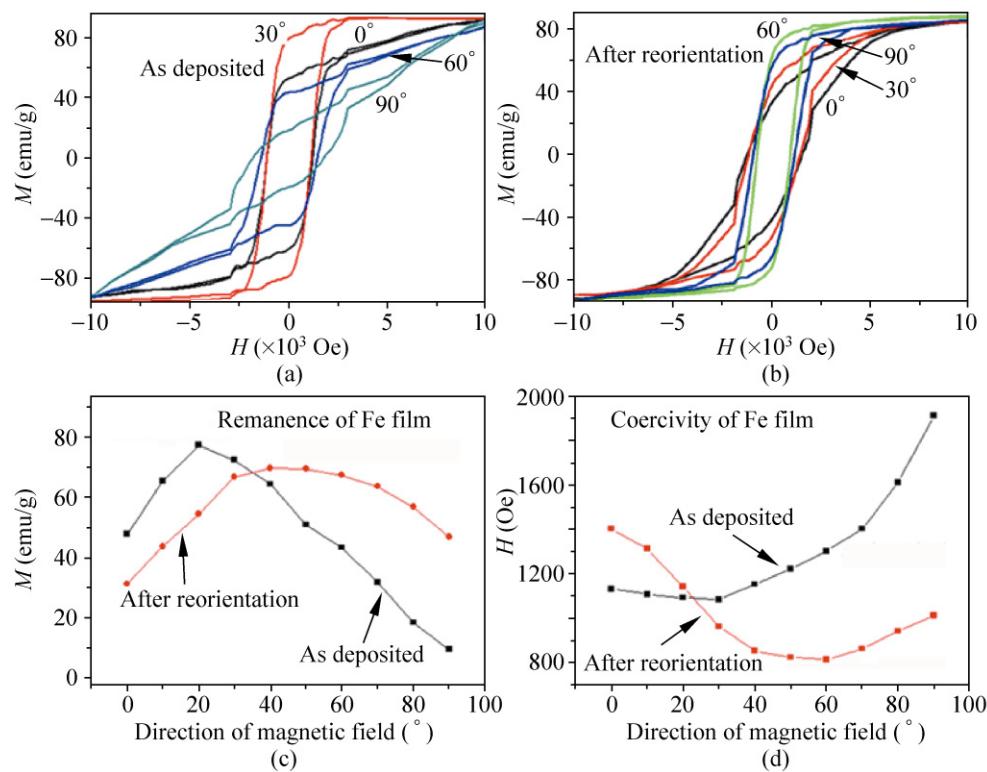


Figure 4 Magnetic hysteresis loops measured in various directions for (a) the as-deposited slanted Fe nanorods and (b) after annealing in a magnetic field of 10 T at 250 °C; (c) and (d) plot the remanence and coercivity of the two samples, measured for various directions of the magnetic field. An angle of 90° means the magnetic field is perpendicular to substrate surface

easy magnetization axis was ~30° from the substrate surface, i.e., close to the axis of the Fe nanorods. It was also found that after annealing the easy magnetization axis was ~60° from the substrate surface, which is also close to the axis of the realigned Fe nanorods. These results indicate that the easy magnetization axis of the nanorods remains along their axis when the Fe nanorods were realigned by the magnetic field during annealing. Figures 4(c) and 4(d) show the remanence and coercivity of the two samples measured with different field directions. Both the maximum remanence and the minimum coercivity moved from angles of ~30° (for the as-deposited sample) to ~60° (for the annealed sample) from the substrate surface, confirming that the easy magnetization axis of the Fe nanorods is along their axis.

In summary, we report here the synthesis of slanted Fe nanorods whose growth axis is the easy magnetization axis, and a method to reorient these slanted nanorods towards the surface normal of the substrate by a strong magnetic field. This study might provide a way to fabricate magnetic nanostructures for perpendicular recording applications.

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